Molex 44914-7002 PDF

深圳创唯电子有限公司

http://www.molex-connect.com



LOW FORCE MICRO-FIT SERIES (46235)



1.0 SCOPE

This Test Summary covers the 3.00 mm (.118 inch) centerline (pitch) receptacles terminated with 46235 low force crimp terminals when mated with either printed circuit board (PCB) headers or plugs terminated with 20 to 30 AWG wire using crimp technology.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME, SERIES, AND PART NUMBER(S)

Micro-Fit (3.0) Receptacle Series: 43025, 43645, 44133 (BMI)

Micro-Fit (3.0) Plug Series: 43020, 43640, 44300 (BMI)

Micro-Fit (3.0) Right Angle & Vertical Header Series: 43045, 43650, 44067

Micro-Fit (3.0) Compliant Pin Vertical Header Series: 44914

Micro-Fit (3.0) Female Crimp Terminal Series: 46235 Micro-Fit (3.0) Male Crimp Terminal Series: 43031

2.1.1 SERIES NUMBERS TESTED

Micro-Fit (3.0) Receptacle: 43025

Micro-Fit (3.0) Plug: 43020

Micro-Fit (3.0) Right Angle & Vertical Headers: 43045

Micro-Fit (3.0) Female Crimp Terminal: 46235 Micro-Fit (3.0) Male Crimp Terminal: 43031

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

Refer to the appropriate sales drawings for information on dimensions, materials, platings and markings.

2.3 PRODUCT SPECIFICATION TITLE AND DOCUMENT NUMBER

Title: Product Specification for Micro-fit Low Mate Force Connector System Document No.: PS-46235-001

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530		ICRO-FIT CONNE		1 of 18
וטו	DATE: 2016 / 10 / 19		SYSTEM		1 01 10
DOCUMEN ^T	ΓNUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	ITH



3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

3.1 TESTING SEQUENCES AND PROCEDURES

Reference Appendix 1

3.2 OTHER DOCUMENTS AND SPECIFICATIONS

SD-46235-001 PS-46235-001

4.0 QUALIFICATION

Laboratory conditions and sample selection are in accordance with EIA-364.

5.0 PERFORMANCE

5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS

(Note that measured LLCR values are for one mated interface)

DESCRIPTION	WIRE GAUGE	REQUIREMENT	AMPERAGE
	30 awg	30° C Max. Temperature Rise	2.5 amps (2 circuit)
Temperature Rise & Current Cycling	26 awg	30° C Max. Temperature Rise	3.0 amps (2 circuit)
	24 awg	30° C Max. Temperature Rise	4.0 amps (2 circuit)
	20 awg	30° C Max. Temperature Rise	5.5 amps (2 circuit)

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530	FORCE M	ICRO-FIT CONNE	CTOR	2 of 18
וֹע	DATE: 2016 / 10 / 19		SYSTEM		2 01 10
DOCUMENT	Γ NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	IITH
			TEMPI ATE EII ENIZ	ME TEST SUMMARY	(ISIZE AI(V 1) DOC



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)(Note that measured LLCR values are for one mated interface)

	WIRE TO BOARD						
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM	
G		Initial	13.0 mΩ Nominal no limit set	12.83 mΩ	12.03 mΩ	13.28 mΩ	
R O U	Contact Resistance (Low Level)	After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.03 mΩ	-0.40 mΩ	0.63 mΩ	
P		After Temp Life (240 hrs. @ 105°C)	20 mΩ MAXIMUM*	0.06 mΩ	-0.39 mΩ	0.61 mΩ	
1		After Reseating (3x M/U)	20 mΩ MAXIMUM*	0.07 mΩ	-0.32 mΩ	0.81 mΩ	

^{*} change from initial

	WIRE TO WIRE							
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM		
G		Initial	13.0 m Ω Nominal no limit set	12.70 mΩ	11.82 mΩ	13.52 mΩ		
R O U	Contact	After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.12 mΩ	-0.31 mΩ	0.78 mΩ		
P	Resistance (Low Level)	After Temp Life (240 hrs. @ 105°C)	20 mΩ MAXIMUM*	0.13 mΩ	-0.27 mΩ	0.54 mΩ		
1		After Reseating (3x M/U)	20 mΩ MAXIMUM*	0.42 mΩ	-0.13 mΩ	1.86 mΩ		

^{*} change from initial

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530	FORCE M	ICRO-FIT CONNE	CTOR	3 of 18
וטו	DATE: 2016 / 10 / 19		SYSTEM		3 01 10
DOCUMENT	Γ NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	IITH
			TEMPI ATE EII ENIA	ME: TEST SUMMARY	(ISIZE AI(V 1) DOC



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)

(Note that measured LLCR values are for one mated interface)

	WIRE TO BOARD							
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM		
		Initial	13.0 m Ω Nominal no limit set	12.99 mΩ	12.58 mΩ	13.51 mΩ		
G R		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.01 mΩ	-0.33 mΩ	0.62 mΩ		
O U P	Contact Resistance (Low Level)	After Thermal Shock	20 mΩ MAXIMUM*	-0.15 mΩ	-0.48 mΩ	0.20 mΩ		
2		After Cyclic Temp and Humidity	20 mΩ MAXIMUM*	-0.14 mΩ	-0.51 mΩ	0.64 mΩ		
		After Reseating (3x M/U)	20 mΩ MAXIMUM*	-0.03 mΩ	-0.39 mΩ	0.52 mΩ		

^{*} change from initial

	WIRE TO WIRE							
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM		
		Initial	13.0 m Ω Nominal no limit set	13.01 mΩ	12.53 mΩ	13.57 mΩ		
G R		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.23 mΩ	-0.41 mΩ	0.66 mΩ		
O U P	Contact Resistance (Low Level)	After Thermal Shock	20 mΩ MAXIMUM*	0.11 mΩ	-0.34 mΩ	0.56 mΩ		
2		After Cyclic Temp and Humidity	20 mΩ MAXIMUM*	0.10 mΩ	-0.41 mΩ	0.51 mΩ		
		After Reseating (3x M/U)	20 mΩ MAXIMUM*	-0.29 mΩ	-0.34 mΩ	0.97 mΩ		

^{*} change from initial

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530	FORCE M	ICRO-FIT CONNE	CTOR	4 of 18
וֹע	DATE: 2016 / 10 / 19		SYSTEM		4 01 10
DOCUMENT	Γ NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	IITH
			TEMPI ATE EII ENI	ME TEST SUMMARY	(ISIZE AI(V 1) DOC



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)

(Note that measured LLCR values are for one mated interface)

		W	/IRE TO BOARD			
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial	13.0 m Ω Nominal no limit set	12.94 mΩ	12.23 mΩ	13.61 mΩ
G R		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.02 mΩ	-0.51 mΩ	0.58 mΩ
O U P	Contact Resistance	After Temp Life (120 hrs. @ 105°C)	20 mΩ MAXIMUM*	0.03 mΩ	-0.50 mΩ	0.35 mΩ
3	(Low Level)	Vibration	20 mΩ MAXIMUM*	0.04 mΩ	-0.29 mΩ	0.82 mΩ
		Mechanical Shock	20 mΩ MAXIMUM*	0.03 mΩ	-0.53 mΩ	0.34 mΩ

^{*} change from initial

			WIRE TO WIRE			
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial	13.0 mΩ Nominal no limit set	13.05 mΩ	12.37 mΩ	13.71 mΩ
G R		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.15 mΩ	-0.25 mΩ	0.61 mΩ
O U P	Contact Resistance	After Temp Life (120 hrs. @ 105°C)	20 mΩ MAXIMUM*	0.28 mΩ	-0.21 mΩ	0.76 mΩ
3	(Low Level)	Vibration	20 mΩ MAXIMUM*	0.44 mΩ	0.07 mΩ	0.93 mΩ
		Mechanical Shock	20 mΩ MAXIMUM*	0.47 mΩ	0.03 mΩ	1.72 mΩ

^{*} change from initial

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530		ICRO-FIT CONNE		5 of 18
וטו	DATE: 2016 / 10 / 19		SYSTEM		3 01 10
DOCUMENT	Γ NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	ITH
	TEMPLATE ELLENAME. TEST SLIMMADVISITE AVV. 1) DOC				



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont) (Note that measured LLCR values are for one mated interface)

		WIRE	TO BOARD, 15µ" Au				
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM	
		Initial	13.0 mΩ Nominal no limit set	12.94 mΩ	12.51 mΩ	13.53 mΩ	
		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.03 mΩ	-0.52 mΩ	0.90 mΩ	
G R		After Temp. Life (120 hrs. @ 105 C)	20 mΩ MAXIMUM*	0.10 mΩ	-0.28 mΩ	1.31 mΩ	
O U P	Contact Resistance		After Mixed Flowing Gas Testing (7 days Unmated)	20 mΩ MAXIMUM*	1.11 mΩ	0.21 mΩ	4.92 mΩ
4	(LOW Level)	After Mixed Flowing Gas Testing (3 days Mated)	20 mΩ MAXIMUM*	1.40 mΩ	0.26 mΩ	6.39 mΩ	
		After Thermal Shock	20 mΩ MAXIMUM*	1.01 mΩ	-0.41 mΩ	33.45 mΩ	
		After Reseating (3x M/U)	20 mΩ MAXIMUM*	0.88 mΩ	-0.17 mΩ	29.43 mΩ	

^{*} change from initial

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	TITLE: TEST SUMMARY FOR 46235 LOW			
D1 EC No: 109530		FORCE M	ICRO-FIT CONNE	CTOR	6 of 18	
וט	DATE: 2016 / 10 / 19		SYSTEM		0 01 10	
DOCUMENT	ΓNUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:	
TS-46235-001		JDFOX SSOUSEK FSMITH			ITH	
	TEMPLATE FILENAME: TEST. SUMMARYISIZE AI(V, 1).				(ISIZE AI(V.1).DOC	



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)

(Note that measured LLCR values are for one mated interface)

		WIRE	TO BOARD, 30μ" Au			
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial	13.0 mΩ Nominal no limit set	12.80 mΩ	12.40 mΩ	13.34 mΩ
		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.02 mΩ	-0.42 mΩ	0.38 mΩ
G R		After Temp. Life (120 hrs. @ 105 C)	20 mΩ MAXIMUM*	-0.01 mΩ	-0.42 mΩ	0.34 mΩ
O U P	Contact Resistance	After Mixed Flowing Gas Testing (7 days Unmated)	20 mΩ MAXIMUM*	0.69 mΩ	-0.25 mΩ	2.61 mΩ
4	(Low Level)	After Mixed Flowing Gas Testing (3 days Mated)	20 mΩ MAXIMUM*	0.71 mΩ	0.08 mΩ	2.79 mΩ
		After Thermal Shock	20 mΩ MAXIMUM*	0.26 mΩ	-0.41 mΩ	1.53 mΩ
		After Reseating (3x M/U)	20 mΩ MAXIMUM*	0.60 mΩ	-0.30 mΩ	2.11 mΩ

^{*} change from initial

REVISION:	ECR/ECN INFORMATION:	TEST SUMMARY FOR 46235 LOW		5 LOW	SHEET No.
D1	EC No: 109530	FORCE M	ICRO-FIT CONNE	CTOR	7 -4 10
וט	DATE: 2016 / 10 / 19		SYSTEM		7 of 18
DOCUMENT	ΓNUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	IITH
	TEMPLATE EN ENAME TEXT OUT AND ADDRESS AND				



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)

(Note that measured LLCR values are for one mated interface)

		WIRE	TO WIRE, 15μ" Au			
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial	13.0 m Ω Nominal no limit set	13.05 mΩ	12.13 mΩ	14.26 mΩ
		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.01 mΩ	-0.35 mΩ	0.44 mΩ
G R		After Temp. Life (120 hrs. @ 105 C)	20 mΩ MAXIMUM*	0.08 mΩ	-0.37 mΩ	0.46 mΩ
O U P	Contact Resistance (Low Level)	After Mixed Flowing Gas Testing (7 days Unmated)	20 mΩ MAXIMUM*	2.07 mΩ	-0.52 mΩ	10.28 mΩ
4	(2011 2010)	After Mixed Flowing Gas Testing (3 days Mated)	20 mΩ MAXIMUM*	1.61 mΩ	0.41 mΩ	5.39 mΩ
		After Thermal Shock	20 mΩ MAXIMUM*	3.23 mΩ	0.28 mΩ	33.62 mΩ
		After Reseating (3x M/U)	20 mΩ MAXIMUM*	2.67 mΩ	0.20 mΩ	12.65 mΩ

^{*} change from initial

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUMMARY FOR 46235 LOW			SHEET No.
			ICRO-FIT CONNE	_	8 of 18
וט	DATE: 2016 / 10 / 19		SYSTEM		0 01 10
DOCUMENT	Γ NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX SSOUSEK FSMITH			IITH
	TEMPI ATE FILENAME: TEST SLIMMARYISIZE AVV 1) D				(ISIZE AI(V 1) DOC



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)

(Note that measured LLCR values are for one mated interface)

		WIRE	TO WIRE, 30μ" Au			
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial	13.0 m Ω Nominal no limit set	12.63 mΩ	12.00 mΩ	13.38 mΩ
		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.14 mΩ	-0.31 mΩ	0.62 mΩ
G R		After Temp. Life (120 hrs. @ 105 C)	20 mΩ MAXIMUM*	0.07 mΩ	-0.39 mΩ	0.55 mΩ
O U P	Contact Resistance (Low Level)	After Mixed Flowing Gas Testing (7 days Unmated)	20 mΩ MAXIMUM*	1.05 mΩ	0.05 mΩ	5.01 mΩ
4	(LOW Level)	After Mixed Flowing Gas Testing (3 days Mated)	20 mΩ MAXIMUM*	1.10 mΩ	0.08 mΩ	7.13 mΩ
		After Thermal Shock	20 mΩ MAXIMUM*	0.86 mΩ	-0.03 mΩ	8.26 mΩ
		After Reseating (3x M/U)	20 mΩ MAXIMUM*	1.34 mΩ	0.23 mΩ	3.88 mΩ

^{*} change from initial

REVISION:	ECR/ECN INFORMATION:	TEST SUMMARY FOR 46235 LOW		5 LOW	SHEET No.
D1	EC No: 109530	FORCE M	ICRO-FIT CONNE	CTOR	0 -4 40
וט	DATE: 2016 / 10 / 19		SYSTEM		9 of 18
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	IITH
	TEMPLATE EN ENAME TEOT OUR MANAGEMENT AND A DOC				



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)

(Note that measured LLCR values are for one mated interface)

	WIRE TO BOARD						
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM	
		Initial	13.0 m Ω Nominal no limit set	12.90 mΩ	12.39 mΩ	13.34 mΩ	
G R O		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.06 mΩ	-0.31 mΩ	0.70 mΩ	
U	Contact Resistance (Low Level)	After Temp. Life (120 hrs. @ 105 C)	20 mΩ MAXIMUM*	0.27 mΩ	-0.15 mΩ	1.08 mΩ	
5		After Thermal Cycling	20 mΩ MAXIMUM*	-0.03 mΩ	-0.37 mΩ	0.63 mΩ	
		After Thermal Shock	20 mΩ MAXIMUM*	0.12 mΩ	-0.37 mΩ	0.61 mΩ	

^{*} change from initial

	WIRE TO WIRE						
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM	
		Initial	13.0 mΩ Nominal no limit set	12.81 mΩ	12.00 mΩ	13.62 mΩ	
G R O		After Initial Durability (Preconditioning) (25 cycles)	20 mΩ MAXIMUM*	0.08 mΩ	-0.50 mΩ	0.62 mΩ	
U	Contact Resistance (Low Level)	After Temp. Life (120 hrs. @ 105 C)	20 mΩ MAXIMUM*	0.22 mΩ	-0.62 mΩ	0.84 mΩ	
5		After Thermal Cycling	20 mΩ MAXIMUM*	0.23 mΩ	-0.48 mΩ	0.85 mΩ	
		After Thermal Shock	20 mΩ MAXIMUM*	0.35 mΩ	-0.54 mΩ	1.42 mΩ	

^{*} change from initial

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUMMARY FOR 46235 LOW			SHEET No.
D1	EC No: 109530	FORCE M	ICRO-FIT CONNE	CTOR	10 of 18
וט	DATE: 2016 / 10 / 19		SYSTEM	SYSTEM	
DOCUMENT	Γ NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX SSOUSEK FSMITH			IITH
TEMPI ATE FII ENAME: TEST SLIMM				ME-TEST SUMMARY	VISIZE AVV 1) DOC



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)

	15μ" Au – 40 cycles					
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	RESULTS		
G R O U P	Dielectric Withstanding Voltage (DWV)	Durability (40 M/U cycles) 2200 VAC	No breakdown or flashover	PASS		

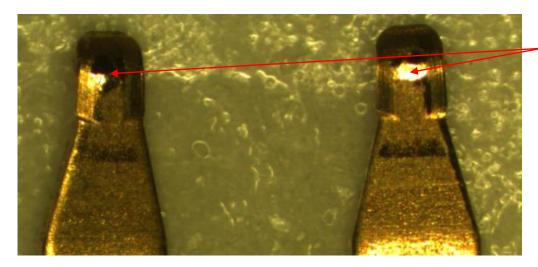


Figure 1 – Contact area shown after 40 cycles

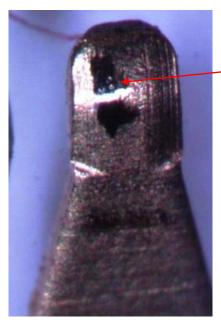
REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530	FORCE M	ICRO-FIT CONNE	CTOR	11 of 18
וט	DATE: 2016 / 10 / 19		SYSTEM		1 1 Of 10
DOCUMENT	ΓNUMBER:	CREATED / REVISED BY:	CHECKED BY:	<u>APPRO\</u>	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	ITH
			TEMPI ATE EII ENIZ	ME TEST SUMMARY	(ISIZE AI(V 1) DOC

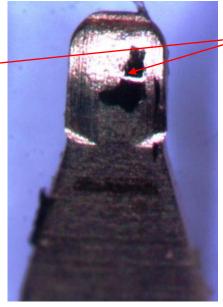
Gold plating present



5.1 ELECTRICAL/ENVIRONMENTAL PERFORMANCE RESULTS (cont)

	15μ" Au – 250 cycles (lubricated)						
ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	RESULTS			
G R O U P	Dielectric Withstanding Voltage (DWV)	Durability (250 M/U cycles) 2200 VAC	No breakdown or flashover	PASS			





Gold plating present

Figure 3 – Contact area shown after 250 cycles

REVISION:	ECR/ECN INFORMATION: EC No: 109530		IMARY FOR 4623!		SHEET No.
D1	DATE: 2016 / 10 / 19	FORCE MICRO-FIT CONNECTOR SYSTEM		OTOR	12 of 18
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	ITH



5.2 MECHANICAL PERFORMANCE RESULTS

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
	2 circuit Connector	Initial Mating	8.0 N maximum	5.52 N	3.81 N	6.88 N
10	Mate and	Initial Un-Mating	4.0 N maximum	2.93 N	2.43 N	3.57 N
1a	Unmate Forces (W-B, 15µ" Au)	Final Mating (after 40 cycles)	8.0 N maximum	4.71 N	3.40 N	5.30 N
	thumb latch removed	Final Un-Mating (after 40 cycles)	4.0 N maximum	3.51 N	1.63 N	4.06 N
	2 circuit Connector	Initial Mating	8.0 N maximum	5.03 N	4.67 N	5.46 N
1b	Mate and Unmate	Initial Un-Mating	4.0 N maximum	2.30 N	2.13 N	2.58 N
16	Forces (W-W, 15µ" Au)	Final Mating (after 40 cycles)	8.0 N maximum	3.59 N	3.27 N	3.87 N
	thumb latch removed	Final Un-Mating (after 40 cycles)	4.0 N maximum	2.32 N	2.10 N	2.51 N
	12 circuit Connector	Initial Mating	48.0 N maximum	15.32 N	13.78 N	17.00 N
10	Mate and	Initial Un-Mating	24.0 N maximum	9.79 N	7.83 N	13.15 N
1c	Unmate Forces (W-B, 15µ" Au)	Final Mating (after 40 cycles)	48.0 N maximum	16.81 N	14.74 N	20.44 N
	thumb latch removed	Final Un-Mating (after 40 cycles)	24.0 N maximum	13.76 N	11.22 N	16.38 N
	12 circuit Connector	Initial Mating	48.0 N maximum	29.39 N	21.65 N	34.27 N
14	Mate and	Initial Un-Mating	24.0 N maximum	18.10 N	13.22 N	21.98 N
1d	Unmate Forces (W-W, 15µ" Au)	Final Mating (after 40 cycles)	48.0 N maximum	24.12 N	19.84 N	28.23 N
	thumb latch removed	Final Un-Mating (after 40 cycles)	24.0 N maximum	19.69 N	14.57 N	23.78 N

DOCUMENT N		CREATED / REVISED BY:	SYSTEM CHECKED BY:	APPROV	13 of 18 (ED BY:
DOCUMENT NUMBER: TS-46235-001		CREATED / REVISED BY: JDFOX		APPROV FSM	



5.2 MECHANICAL PERFORMANCE RESULTS (cont)

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
	24 circuit Connector	Initial Mating	96.0 N maximum	37.93 N	33.42 N	42.50 N
10	Mate and	Initial Un-Mating	48.0 N maximum	21.82 N	19.98 N	23.35 N
1e	Unmate Forces (W-B, 15µ" Au)	Final Mating (after 40 cycles)	96.0 N maximum	34.04 N	31.42 N	36.26 N
	thumb latch removed	Final Un-Mating (after 40 cycles)	48.0 N maximum	25.35 N	23.77 N	27.13 N
	24 circuit Connector	Initial Mating	96.0 N maximum	52.61 N	47.20 N	61.89 N
1f	Mate and	Initial Un-Mating	48.0 N maximum	29.87 N	27.53 N	32.68 N
''	Unmate Forces (W-W, 15µ" Au)	Final Mating (after 40 cycles)	96.0 N maximum	43.80 N	40.78 N	45.15 N
	thumb latch removed	Final Un-Mating (after 40 cycles)	48.0 N maximum	36.45 N	32.49 N	39.52 N

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530	FORCE M	ICRO-FIT CONNE	CTOR	14 of 18
וטו	DATE: 2016 / 10 / 19		SYSTEM		14 01 10
DOCUMEN ^T	ΓNUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	ITH
			TEMPLATE FILENA	ME: TEST_SUMMARY	(ISIZE AI(V.1).DOC



5.2 MECHANICAL PERFORMANCE RESULTS (cont)

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
2	Terminal Retention Force (in housing)		24.5 N per contact minimum	36.4 N	35.4 N	37.9 N
3	Terminal Insertion Force (in housing)		14.7 N per contact maximum	2.9 N	2.2 N	4.2 N
		20 awg	57.8 N minimum	107.4 N	97.0 N	116.0 N
		22 awg	35.6 N minimum	80.7 N	71.8 N	86.0 N
4	Wire Pullout Force	24 awg	22.2 N minimum	50.45 N	46.0 N	56.0 N
7	(from terminal)	26 awg	13.3 N minimum	28.7 N	24.0 N	31.0 N
		28 awg	8.9 N minimum	17.1 N	15.0 N	19.0 N
		30 awg	6.6 N minimum	9.4 N	9.0 N	10.0 N
5	Normal Force	Initial	50 g per contact beam minimum	134.8 g	120.8 g	143.3 g
j J	(nominal deflection)	After one cycle	50 g per contact beam minimum	134.3 g	121.8 g	143.6 g

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530		ICRO-FIT CONNE	_	15 of 18
וט	DATE: 2016 / 10 / 19		SYSTEM		13 01 16
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	ITH
			TEMPLATE FILENA	ME: TEST_SUMMARY	(ISIZE AI(V.1).DOC



6.0 APPENDIX 1

6.1 TEST SEQUENCES

GROUP 1	GROUP 2	GROUP 3	GROUP 4	GROUP 5	GROUP 7
Visual Exam	Visual Exam				
LLCR	LLCR	LLCR	LLCR	LLCR	LLCR
Preconditioning Durability (25 M/U cycles)	Durability (40 M/U cycles)				
LLCR	LLCR	Temp Life (120 hrs @ 105°)	LLCR	LLCR	LLCR
Temp Life (240 hrs @ 105°)	Thermal Shock	LLCR	Temp Life (120 hrs @ 105°)	Temp Life (120 hrs @ 105°)	DWV
LLCR	LLCR	Vibration	LLCR	LLCR	Visual Exam
Reseating	Cyclic Temp and Humidity	LLCR	MFG (7 days Unmated)	Thermal Cycling	
LLCR	LLCR	Mechanical Shock	LLCR	LLCR	
	Reseating	LLCR	MFG (3 days Mated)	Thermal Shock	
	LLCR		LLCR	LLCR	
			Thermal Shock	Reseating	
			LLCR	LLCR	
			Reseating		
			LLCR		

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.
D1	EC No: 109530	FORCE MICRO-FIT CONNECTOR		CTOR	16 of 18
ו ט	DATE: 2016 / 10 / 19		SYSTEM		100110
DOCUMENT	ΓNUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-46235-001		JDFOX	SSOUSEK	FSM	ITH
			TEMPI ATE EII ENA	ME: TEST SUMMARY	(ISIZE AI(V 1) DOC



6.2 TEST PROCEDURES

ITEM	TEST CONDITION
LOW LEVEL CONTACT RESISTANCE (LLCR)	per EIA-364-TP-23
INITIAL MATING FORCE	per EIA-364-TP-13
INITIAL UN-MATING FORCE	per EIA-364-TP-13
DURABILITY	per EIA-364-TP-09
RANDOM VIBRATION	per EIA-364-TP-28, Test Cond. VII
MECHANICAL SHOCK	per EIA-364-TP-27 Peak Value: 50 G; Duration: 11 mSec.; Waveform: Half Sine; # Shocks Direction: 3 shocks/3 axes (18 total)
NORMAL FORCE	per EIA-364-04 (perpendicular force)
THERMAL AGING (Temp life)	per EIA-364-TP-17, method A
THERMAL SHOCK	per EIA-364-TP-32
CYCLIC HUMIDITY	per EIA-364-TP-31 Test Temp: +40° ± 2° C Relative Humidity: 90 to 95%; Test Duration: 96 hours
MIXED FLOWING GAS (MFG)	per EIA-364-TP-65, Option 2, Class IIA
Dielectric Withstanding Voltage (DWV)	per EIA-364-TP-20 Method B
Insulation Resistance	per EIA-364-TP-21
Current Carrying Capacity (CCC)	per EIA-364-TP-70 Method 2

D1	CR/ECN INFORMATION: C No: 109530 DATE: 2016 / 10 / 19	TEST SUM FORCE M	17 of 18		
DOCUMENT NUMBER: TS-46235-001		CREATED / REVISED BY: JDFOX	CHECKED BY: SSOUSEK	APPROV FSM	



7.0 REVISION HISTORY

Revision Level:	Created / Revised By:	Revision Description:	Date of Revision
Α	T. Gregori	Initial "A" Release	7/09/08
В	T. Gregori	Revised Group 4 data based on test results, section 5.1	7/28/08
С	T. Gregori	T-Rise table added; Group 7 250 cycle table added	11/20/08
D	T. Gregori	Revised mate / un-mate force; added total forces for 2, 12 and 24 ckts (items 1a thru 1f)	8/5/09
D1	JDFOX	Add series detail to sections 2.1 & 2.1.1	10/19/16

REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUM	IMARY FOR 4623	5 LOW	SHEET No.			
D1	EC No: 109530		ICRO-FIT CONNE	_	18 of 18			
וט	DATE: 2016 / 10 / 19		SYSTEM					
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:			
TS-46235-001		JDFOX	JDFOX SSOUSEK FSMITH					
TEMPLATE FILENAME: TEST. SUMMARYISIZE AI(V.1).DOC								

PRODUCT SPECIFICATION

MICRO-FIT

1.0 SCOPE

This Product Specification covers the performance requirements and test methods of Micro-Fit 3.00 mm (.118 inch) centerline (pitch) wire to board and wire to wire connector systems terminated with 18 to 30 AWG stranded wire using crimp technology with tin or gold plating.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME AND SERIES NUMBERS

Female Crimp Terminal: 43030 Receptacle: 43025 TPA (for 172952): 172953 TPA Receptacle: 172952 Male Crimp Terminal: 43031 Pluq: 43020

Headers: 43045, 44914

Test Plua: 44242 (recommended for continuity testing only)

Other products conforming to this specification are noted on the individual drawings.

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

Receptacle and Plug - Polyester, Nylon; Headers - LCP Housings:

Terminal: Phosphor Bronze

Pins: Brass, Modified Tin/Brass

2.3 SAFETY AGENCY APPROVALS

File Numbers:

UL: E29179 CSA: LR19980

IEC 61984 Certification: Tested to and found in compliance with IEC 61984. NRTL type examination certificate available from Molex upon request. Contact Molex Safety Agency team for questions regarding certification on specific part numbers.

3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

Test Summary: TS-43045-001

Application Spec: AS-45499-001 (moisturizing nylon parts)

4.0 RATINGS

4.1 SAFETY AGENCY RATINGS

DEVISION: ECD/ECN INFORMATION: TITLE:

	Agency Voltage Rating (AC RMS or DC)			Agency Current Rating (Single Circuit (Amps)		
Series	UL	CSA	IEC	UL	CSA	IEC
43020	350	600	250	5	7	5
43025	600	600	250	8	8	5
172952	600	600	pending	5	7	pending
43045	600	600	250	8	8	5
44914	600	600	250	8	8	5

Current ratings are maximum and may vary depending on wire size, circuit count, and end-use application. Further testing may be required in the end-use application.

P	EC No: UCP2018-0645 DATE: 2017/10/27		JCT SPECIFICATI MICRO-FIT ROW CONNECTORS		1 of 10
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
PS-43045		SSOUSEK	JBELL FSMITH		ITH
TEMPLATE FILENAME: PRODUCT SPECISIZE AVV 1) DOC					

CLIEFT No

PRODUCT SPECIFICATION

4.2 CURRENT DERATING AND APPLICABLE WIRES

Current is dependent on connector size, contact material, plating, ambient temperature, printed circuit board characteristics and related factors. Actual current rating is application dependent and should be evaluated for each application.

Stranded Copper Wire Size	Max. Outside Insulation Diameter
18 AWG	1.85 mm (.073 inch)
0.75 mm ²	1.85 mm (.073 inch)
20 AWG	1.85 mm (.073 inch)
22 AWG	1.85 mm (.073 inch)
24 AWG	1.85 mm (.073 inch)
26 AWG	1.27 mm (.050 inch)
28 AWG	1.27 mm (.050 inch)
30 AWG	1.27 mm (.050 inch)

CURRENT DERATING REFERENCE INFORMATION								
AWG and	2-circuit		6-circuit		12-circuit		24-circuit	
Metric	W-W	W-B	W-W	W-B	W-W	W-B	W-W	W-B
Wire Size	Amps	Amps	Amps	Amps	Amps	Amps	Amps	Amps
18 AWG	7	8.5	6	6.5	5.5	5.5	5	5
20 AWG or 0.75mm ²	6.5	7	5	* 5.5	4.5	* 5	* 4	4.5
22 AWG	5.5	* 6	* 4	* 4.5	* 3.5	* 4	* 3	* 3.5
24 AWG	5	5.5	4	* 4.5	3	* 3.5	* 2	* 3
26 AWG	4	4.5	3	* 4	2.5	* 3.5	* 1.5	2.5
28 AWG	3	* 4	* 2	* 3	* 2	* 3	* 1	* 2
30 AWG	3	3.5	2	* 3	2	* 2.5	* 1	1

- 1) Values are for REFERENCE ONLY.
- 2) Current deratings are based on not exceeding 30°C Temperature Rise.
- 3) Testing conducted using tinned stranded copper wire and tin plated terminals.
- 4) PCB trace design can greatly affect temperature rise results in Wire-to-Board applications.
- 5) Data is for all circuits powered.
- 6) * indicates interpolated information.
- 7) W-W: Wire-to-Wire W-B: Wire-to-Board

REVISION:	ECR/ECN INFORMATION: EC No: UCP2018-0645	TITLE: PRODU	JCT SPECIFICATION	ON -	ET No. of 10
•	DATE: 2017/10/27	DUA			
DOCUMENT	ΓNUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPROVED BY	<u>Y:</u>
PS-43045		SSOUSEK	JBELL FSMITH		
TEMPLATE FILENAME: PRODUCT SPECISIZE AI(V.1).DOC					

PRODUCT SPECIFICATION

4.3 CURRENT FOR TEST PLUG 44242

2.5 Amps Maximum (Pogo pin current capacity)
Test plugs are for testing purposes only and not intended for continuous use.

4.4 TEMPERATURE

Operating: - 40°C to + 105°C (Including Terminal Temperature Rise)

Non-operating: - 40°C to + 105°C

P	ECR/ECN INFORMATION: EC No: UCP2018-0645 DATE: 2017/10/27		JCT SPECIFICATION MICRO-FIT ROW CONNECTORS		3 of 10
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
PS-43045		SSOUSEK	JBELL FSMITH		IITH
TEMPLATE FILENAME: PRODUCT SPEC[SIZE A](V.1).DOC					

molex[®]

PRODUCT SPECIFICATION

5.0 PERFORMANCE

5.1 ELECTRICAL REQUIREMENTS

DESCRIPTION	TEST CONDITION	REQUIREMENT
Contact Resistance (Low Level)	Mate connectors: apply a maximum voltage of 20 mV and a current of 100 mA. (Does not include wire resistance)	10 milliohms MAXIMUM [initial]
Contact Resistance of Wire Termination (Low Level)	Terminate the applicable wire to the terminal and measure wire using a voltage of 20 mV and a current of 100 mA.	5 milliohms MAXIMUM [initial]
Insulation Resistance	Unmate & unmount connectors: apply a voltage of 500 VDC between adjacent terminals and between terminals to ground.	1000 Megohms MINIMUM
Dielectric Withstanding Voltage	Unmate connectors: apply a voltage of {two times the rated voltage plus 1000 volts} VAC for 1 minute between adjacent terminals and between terminals to ground.	No breakdown; current leakage < 5 mA
Capacitance	Measure between adjacent terminals at 1 MHz.	2 picofarads MAXIMUM
Temperature Rise (via Current Cycling)	Mate connectors: measure the temperature rise at the rated current after: 1) 96 hours (steady state) 2) 240 hours (45 minutes ON and 15 minutes OFF per hour) 3) 96 hours (steady state)	Temperature rise: +30°C MAXIMUM

5.2 MECHANICAL REQUIREMENTS

DESCRIPTION	TEST CONDITION	REQUIREMENT
Connector Mate and Unmate Forces	Mate and unmate connector (male to female) at a rate of 25 ± 6 mm (1 ± ½ inch) per minute. (Per circuit)	8.0 N (1.8 lbf) per circuit MAXIMUM mate force & 2.4 N (0.5 lbf) per circuit MINIMUM unmate force
Crimp Terminal Retention Force (in Housing)	Axial pullout force on the terminal in the housing at a rate of 25 \pm 6 mm (1 \pm $\frac{1}{4}$ inch) per minute.	24.5 N (5.5 lbf) MINIMUM retention force

P REVISION:	ECR/ECN INFORMATION: EC No: UCP2018-0645 DATE: 2017/10/27		JCT SPECIFICATION MICRO-FIT ROW CONNECTORS		4 of 10
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
PS-43045		SSOUSEK	JBELL	FSMITH	
TEMPLATE FUENAME, PRODUCT SPECIFIE A14/4) DOC					

TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A](V.1).DOG

PRODUCT SPECIFICATION

5.2 MECHANICAL REQUIREMENTS, cont.

Crimp Terminal Insertion Force (into Housing)	Apply an axial insertion force on the terminal at a rate of 25 \pm 6 mm (1 \pm $\frac{1}{4}$ inch) per minute.	14.7 N (3.3 lbf) MAXIMUM insertion force
Durability	Mate connectors up to 30 cycles at a maximum rate of 10 cycles per minute.	20 milliohms MAXIMUM (change from initial)
Vibration (Random)	Mate connectors and vibrate per EIA 364-28, test condition VII, Letter D. Test Duration: 15 minutes each axis.	20 milliohms MAXIMUM (change from initial) & Discontinuity < 1 microsecond
Shock (Mechanical)	Mate connectors and shock at 50 g's with ½ sine wave (11 milliseconds) shocks in the ±X,±Y,±Z axes (18 shocks total). (Per EIA-364-27, Test Condition H)	20 milliohms MAXIMUM (change from initial) & Discontinuity < 1 microsecond
Wire Pullout Force (Axial) (Wire from Terminal)	Apply an axial pullout force on the wire at a rate of 25 ± 6 mm ($1 \pm \frac{1}{4}$ inch) per minute.	MINIMUM pullout force 18 awg: 89.0 N (20.0 lbf) 0.75 mm2: 89.0 N (20.0 lbf) 20 awg: 57.8 N (13.0 lbf) 22 awg: 35.6 N (8.0 lbf) 24 awg: 22.2 N (5.0 lbf) 26 awg: 13.3 N (3.0 lbf) 28 awg: 8.9 N (2.0 lbf) 30 awg: 6.6 N (1.5 lbf) Values may vary depending on crimp tooling. Refer to Molex Applicator Tooling Specification.
Normal Force	Apply a perpendicular force.	2.7 N (0.6 lbf) MINIMUM
Pin to Header Retention	Apply axial push force to pin at a rate of 25 \pm 6 mm (1 \pm ¼ inch) per minute.	13.7 N (3.1 lbf) MINIMUM pushout force
Thumb Latch to Ramp Yield Strength	Full mate and then Unmate the connectors at a rate of 25 \pm 6 mm (1 \pm $\frac{1}{4}$ inch) per minute.	58.0 N (13.0 lbf) MINIMUM Yield Strength
Panel Mount Retention	Insert connector in panel. Apply an axial force on the connector in the opposite direction of insertion at a rate of 25 ± 6 mm $(1 \pm \frac{1}{4} \text{ inch})$ per minute.	155.7 N (35 lbf) MINIMUM pushout force

P REVISION:	ECR/ECN INFORMATION: EC No: UCP2018-0645 DATE: 2017/10/27		JCT SPECIFICATION MICRO-FIT ROW CONNECTORS		5 of 10
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
PS-43045		SSOUSEK	JBELL	FSM	ITH
			TEMPLATE FILENA	ME: PRODUCT_SPEC	[SIZE_A](V.1).DOC

PRODUCT SPECIFICATION

5.2 MECHANICAL REQUIREMENTS, cont.

Compliant Pin Insertion Force into PCB Hole (44914 Series)	Apply an axial insertion force on the terminal at a rate of 25 ± 6 mm $(1 \pm \frac{1}{4}$ inch) per minute.	106.7 N (24 lbf) Maximum Insertion force (Per Terminal) ⁽¹⁾
Compliant Pin Retention Force in PCB Hole (44914 Series)	Apply an axial extraction force on the terminal at a rate of 25 ± 6 mm (1 $\pm \frac{1}{4}$ inch) per minute.	35.6 N (8 lbf) Minimum Retention force (Per Terminal) ⁽¹⁾

⁽¹⁾ Based on results using Printed Circuit Board (PCB) with Tin PTH finish. Pin left undisturbed in PCB a minimum of 24 hours after insertion prior to testing Retention Force. PCB with different design or finish may vary from these results

5.3 ENVIRONMENTAL REQUIREMENTS

DESCRIPTION	TEST CONDITION	REQUIREMENT
Thermal Aging	Mate connectors; expose to: 240 hours at 105 ± 2°C OR 500 hours at 85 ± 2°C	20 milliohms MAXIMUM (change from initial])
Humidity (Steady State)	Mate connectors: expose to a temperature of 40 ± 2°C with a relative humidity of 90-95% for 96 hours. Note: Remove surface moisture and air dry for 1 hour prior to measurements.	20 milliohms MAXIMUM (change from initial) & Dielectric Withstanding Voltage: No Breakdown at 500 VAC & Insulation Resistance: 1000 Megohms MINIMUM
Solderability	Per SMES-152	Solder coverage: 95% MINIMUM (per SMES-152)
Solder Resistance	A) Wave Solder Process Dip connector terminal tails in solder; Solder Duration: 10 seconds MAX Solder Temperature: 260°C MAX Per AS-40000-5013 B) Convection Reflow Solder Process 260°C MAX Per AS-40000-5013	Visual: No Damage to insulator material

P	ECR/ECN INFORMATION: EC No: UCP2018-0645 DATE: 2017/10/27		JCT SPECIFICATION MICRO-FIT ROW CONNECTORS	6 of 10
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPROVED BY:
PS-43045		SSOUSEK	JBELL	FSMITH
TEMPLATE FILENAME: PRODUCT SPECISIZE AI(V.1).DOC				

PRODUCT SPECIFICATION

5.3 ENVIRONMENTAL REQUIREMENTS, cont.

Salt Spray	Mate connectors Orientation: Horizontal with latch on top surface Duration: 48 hours exposure Atmosphere: Salt spray from a 5% solution Temperature: 35 ± 2°C	20 milliohms MAXIMUM (change from initial)
Cold Resistance	Mate connectors Duration: 96 hours Temperature: -40 ± 3°C	20 milliohms MAXIMUM (change from initial)

6.0 PACKAGING

Parts shall be packaged to protect against damage during handling, transit and storage per the packaging specifications listed below:

Receptacle, TPA Receptacle, TPA, and Plug: Bulk Packaged Headers: PK-70873-0313, PK-70873-0314, PK-70873-05**.

7.0 GAGES AND FIXTURES

It is recommended that test plugs (Series 44242) be used for continuity testing of receptacles. Standard mating parts should not be used for harness testing.

NOTE: The use of unauthorized testing devices and/or probes with a Molex product may cause damage to and affect functionality of the Molex product, and such use may void any and all warranties, expressed or implied.

DUAL	MICRO-FIT L ROW CONNECTORS		7 of 10
TED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
SSOUSEK	JBELL	FSM	ITH
	TED / REVISED BY:	TED / REVISED BY: CHECKED BY:	

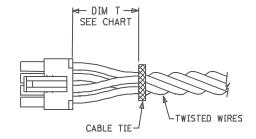
TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A](V.1).DOC

PRODUCT SPECIFICATION

8.0 OTHER INFORMATION

8.1 CABLE TIE AND OR WIRE TWIST LOCATION

CKT Sizes	Dim T Min.
2-8	.500 (12.70)
10-16	.750 (19.10)
18-24	1.000 (25.40)



The "T" dimension defines a "free" length of wire, or a length of wire that is not subject to significant bias by external factors such as a wire tie, wire twisting, or other means of bending or deforming of the wires that repositions them from their natural relaxed state or location where they enter the housing. Wires are to be dressed in such a manner to allow the terminals to float freely in the pocket.

8.2 CONTACT ENGAGEMENT (WIPE) FOR FULLY MATED NOMINAL COMPONENTS (For Reference Only)

Receptacle	Mated to Plug/ Header	Application	Contact Wipe
43025 Receptacle ⁽¹⁾	43020 Plug	Wire-to-Wire	0.083 in/(2.11 mm)
	43045 Header 44914 CPI Header	Wire-to-Board	0.069 in/(1.75 mm)
172952	43020 Plug	Wire-to-Wire	0.072 in/(1.84 mm)
TPA Receptacle ⁽¹⁾	43045 Header 44914 CPI Header	Wire-to-Board	0.063 in/(1.60 mm)

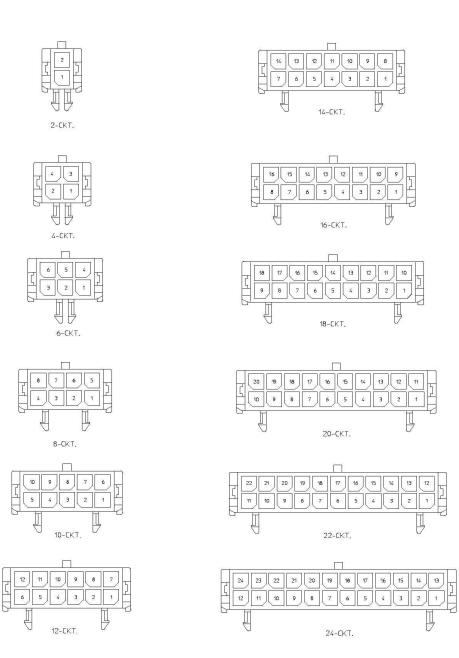
Note (1): Contact Wipe is based on 43030 female crimp terminal. If using 46235 female crimp terminal, reduce Contact Wipe by .005 in/(0.13 mm).

P REVISION:	ECR/ECN INFORMATION: EC No: UCP2018-0645 DATE: 2017/10/27		JCT SPECIFICATION MICRO-FIT L ROW CONNECTORS		8 of 10
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
PS-43045		SSOUSEK	JBELL	FSM	ITH
	1 0-40040	3333211		1 011.	

TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A](V.1).DOC

PRODUCT SPECIFICATION

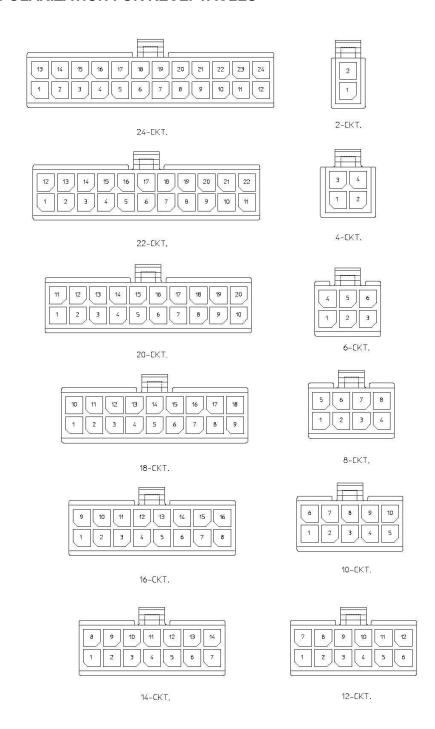
8.3 STANDARD POLARIZATION FOR HEADERS AND PLUGS (HEADERS ARE SHOWN)



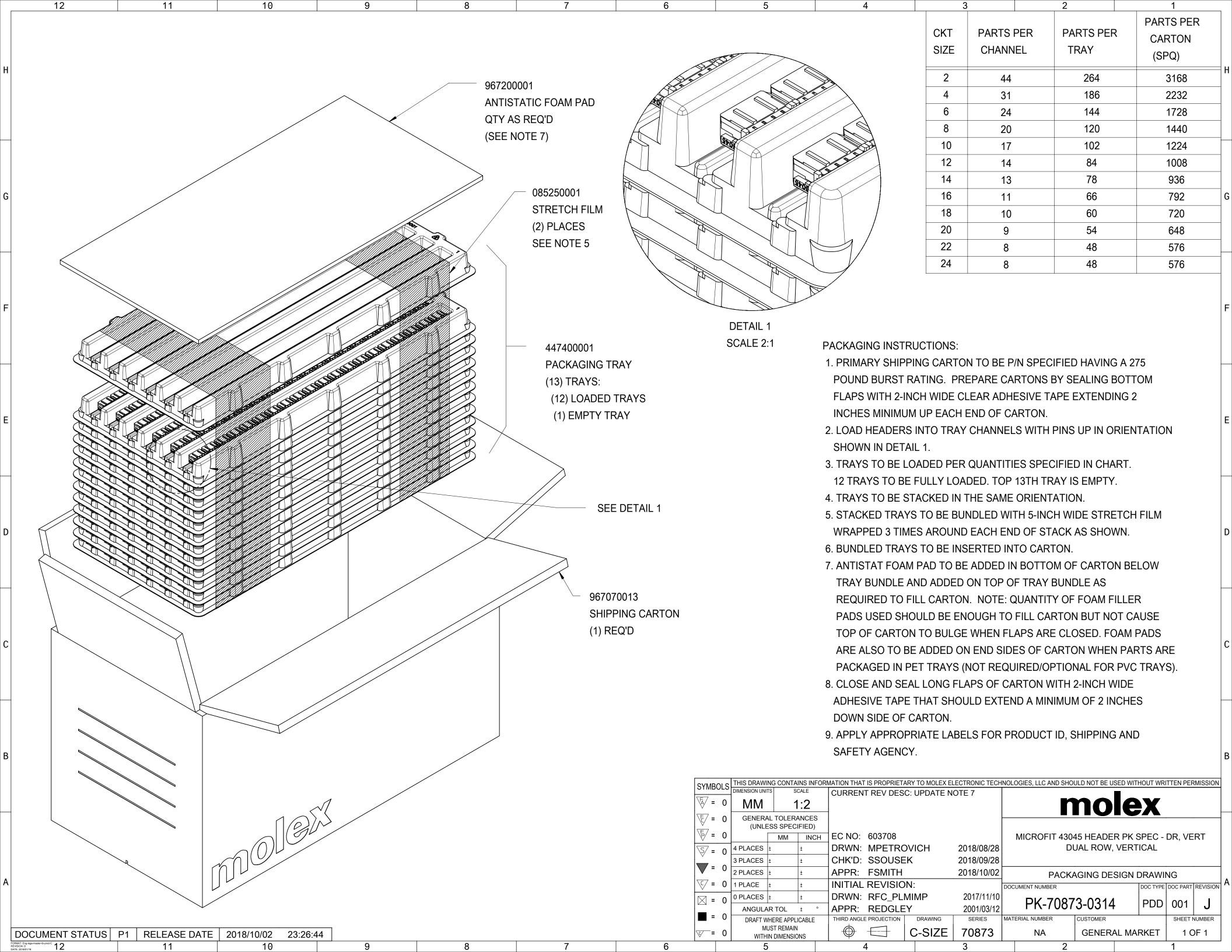
P REVISION:	ECR/ECN INFORMATION: EC No: UCP2018-0645 DATE: 2017/10/27		JCT SPECIFICATION MICRO-FIT ROW CONNECTORS		9 of 10
DOCUMEN'	T NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
PS-43045		SSOUSEK	JBELL	FSM	ITH
			TEMPLATE FILENA	ME: PRODUCT_SPEC	SSIZE_A](V.1).DOC

PRODUCT SPECIFICATION

8.4 STANDARD POLARIZATION FOR RECEPTACLES



REVISION:	ECR/ECN INFORMATION:	PRODUCT SPECIFICATION		SHEET No.	
Р	EC No: UCP2018-0645		MICRO-FIT		10 of 10
•	DATE: 2017/10/27	DUAI	L ROW CONNECTORS		
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	VED BY:
PS-43045		SSOUSEK	JBELL	FSM	IITH
TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A](V.1).DOC					





Micro-Fit (3.0) Connector System (Wire to Wire & Wire to Board)

1.0 SCOPE

This Test Specification covers the 3.00 mm (.118 inch) centerline (pitch) connector series terminated with 20-30 AWG wire using crimp technology.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME, SERIES, AND PART NUMBER(S)

Micro-Fit (3.0) Receptacle Series: 43025, 43645, 44133 (BMI)

Micro-Fit (3.0) Plug Series: 43020, 43640, 44300 (BMI)

Micro-Fit (3.0) Right Angle & Vertical Header Series: 43045, 43650, 44067

Micro-Fit (3.0) Compliant Pin Vertical Header Series: 44914

Micro-Fit (3.0) Female Crimp Terminal Series: 43030 Micro-Fit (3.0) Male Crimp Terminal Series: 43031

Micro-Fit (3.0) Female Crimp Terminal with Lubricant: 45773

2.1.1 SERIES NUMBERS TESTED

Micro-Fit (3.0) Receptacle: 43025

Micro-Fit (3.0) Plug: 43020

Micro-Fit (3.0) Right Angle & Vertical Headers: 43045

Micro-Fit (3.0) Female Crimp Terminal: 43030 Micro-Fit (3.0) Male Crimp Terminal: 43031

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See the appropriate sales drawings for information on dimensions, materials, plating, and markings.

2.3 PRODUCT SPECIFICATION TITLE AND DOCUMENT NUMBER

Product Specification Micro-Fit Dual Row Connectors

Document Number: PS-43045

Product Specification Micro-Fit Single Row Connectors

Document Number: PS-43650

Product Specification Micro-Fit (3.0) BMI Floating Connector System

Document Number: PS-44300-001

3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

3.1 TESTING PROCEDURES AND SEQUENCES

EIA-364-1000.01

REVISION:	ECR/ECN INFORMATION: EC No: 109530				SHEET No.
A2	DATE: 2016 / 10 /18	MICRO-FIT (3.0) CONNECTORS			1 of 10
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	ED BY:
TS-43045-001		JDFOX	SSOUSEK	FSM	ITH

molex TEST SUMMARY

3.2 OTHER DOCUMENTS AND SPECIFICATIONS None

4.0 QUALIFICATION

Laboratory conditions and sample selection are in accordance with EIA-364.

5.0 PERFORMANCE RESULTS

5.1 ELECTRICAL PERFORMANCE RESULTS

WIRE TO WIRE CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial **	10 milliohms MAXIMUM	19.95 mΩ	19.74 mΩ	20.40 mΩ
	CONTACT RESISTANCE (LOW LEVEL)	After Durability $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	-0.23 mΩ	-0.03 mΩ	0.67 mΩ
1A		After Temperature Life Δ m Ω	20 milliohms MAXIMUM	0.38 mΩ	0.08 mΩ	1.01 mΩ
		After Reseating $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	0.25 mΩ	-0.53 mΩ	1.32 mΩ

NOTE: **APPROXIMATELY 16.6 mΩ OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE 13 INCHES OF WIRE USED IN SAMPLE PREPARATION.

WIRE TO BOARD CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial	10 milliohms MAXIMUM	4.75 m Ω	4.55 mΩ	4.98 mΩ
	_ CONTACT	After Durability $\Delta \ m \Omega$	20 milliohms MAXIMUM	-0.23 mΩ	-0.03 mΩ	0.67 mΩ
1B	RESISTANCE (LOW LEVEL)	After Temperature Life Δ m Ω	20 milliohms MAXIMUM	0.38 mΩ	0.08 mΩ	1.01 mΩ
		After Reseating $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	0.25 mΩ	-0.53 mΩ	1.32 mΩ

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE DESCRIPTION.

REVISION:	ECR/ECN INFORMATION:	TITLE:	TLE: TEST SUMMARY			
A2	EC No: 109530		IICRO-FIT (3.0)		2 of 10	
AZ	DATE: 2016 / 10 /18		CONNECTORS			
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	<u>APPRO</u> V	/ED BY:	
TS-43045-001		JDFOX	SSOUSEK	FSMITH		
TEMPLATE FUENAME, TEST SUMMAPVIOLE AVVAILABLE						

molex TEST SUMMARY

ELECTRICAL PERFORMANCE RESULTS (continued) 5.1

WIRE TO WIRE CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial **	10 milliohms MAXIMUM	20.01 mΩ	19.59 mΩ	23.29 mΩ
		After Durability $\Delta \ m \Omega$	20 milliohms MAXIMUM	0.19 mΩ	-0.02 mΩ	0.64 mΩ
2A	Contact Resistance	After Thermal Shock Δ m Ω	20 milliohms MAXIMUM	0.34 mΩ	0.08 mΩ	0.74 mΩ
	(Low Level)	After Cyclic Humidity $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	0.62 mΩ	0.14 mΩ	1.77 mΩ
		After Reseating $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	0.61 mΩ	0.11 mΩ	1.77 mΩ

NOTE: **APPROXIMATELY 16.6 m Ω OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE 13 INCHES OF WIRE USED IN SAMPLE PREPARATION.

WIRE TO BOARD CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial	10 milliohms MAXIMUM	4.75 m $Ω$	4.55 mΩ	4.98 m $Ω$
		After Durability $\Delta \ m \Omega$	20 milliohms MAXIMUM	0.42 mΩ	-0.02 mΩ	2.03 mΩ
2B	Contact Resistance	After Thermal Shock Δ m Ω	20 milliohms MAXIMUM	1.56 mΩ	0.25 mΩ	5.71 mΩ
	(Low Level)	After Cyclic Humidity $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	1.28 mΩ	0.15 mΩ 4.6	4.60 mΩ
		After Reseating $\Delta \ m \Omega$	20 milliohms MAXIMUM	2.19 mΩ	0.23 mΩ	8.04 mΩ

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE DESCRIPTION

REVISION:	ECR/ECN INFORMATION:	TEST SUMMARY		SHEET No.	
Λ 2	EC No: 109530	N	IICRO-FIT (3.0)		3 of 10
A2	DATE: 2016 / 10 /18		CONNECTÒRS		
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-43045-001		JDFOX	SSOUSEK	FSM	ITH



ELECTRICAL PERFORMANCE RESULTS (continued) 5.1

WIRE TO BOARD CONFIGURATION - 2 CIRCUIT VERSION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial **	10 milliohms MAXIMUM	10.26 m Ω	10.17 mΩ	10.46 mΩ
		After Durability $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	0.75 mΩ	0.16 mΩ	1.57 mΩ
3A	Contact Resistance (Low Level)	After Temperature Life Pre-Conditioned $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	1.88 mΩ	0.58 mΩ	3.77 mΩ
		After Vibration	20 milliohms MAXIMUM	1.28 mΩ	0.15 mΩ	4.60 mΩ
		Δ m Ω	No Discontinuity	Discontinuity < 1 microsecond		rosecond

NOTE: ** APPROXIMATELY 7.8 m Ω OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE 6 INCHES OF WIRE USED IN SAMPLE PREPARATION.

WIRE TO BOARD CONFIGURATION -12 CIRCUIT VERSION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial **	10 milliohms MAXIMUM	10.24 mΩ	9.85 m Ω	10.52 m Ω
		After Durability $\Delta \ \text{m}\Omega$	20 milliohms MAXIMUM	0.41 mΩ	0.14 mΩ	2.13 mΩ
3В	Contact Resistance (Low Level)	After Temperature Life Pre-Conditioned Δ m Ω	20 milliohms MAXIMUM	0.81 mΩ	0.16 mΩ	3.68 mΩ
		After Vibration	20 milliohms MAXIMUM	1.14 mΩ	0.25 mΩ	3.56 mΩ
		Δ m Ω	No Discontinuity	Discontinuity < 1 microsecond		rosecond

NOTES: ** APPROXIMATELY 7.8 m Ω OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE 6 INCHES OF WIRE USED IN SAMPLE PREPARATION.

SEE APPENDIX "A" FOR TEST SEQUENCE DESCRIPTION

REVISION:	ECR/ECN INFORMATION:	TITLE:	TLE: TEST SUMMARY		
A2	EC No: 109530		IICRO-FIT (3.0)		4 of 10
AZ	DATE: 2016 / 10 /18		CONNECTORS		
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	<u>APPRO</u> V	/ED BY:
TS-43045-001		JDFOX	SSOUSEK	FSMITH	
TEMPLATE ELEMAND, TECT CUMMADVICITE ANVALOGO					



ELECTRICAL PERFORMANCE RESULTS (continued) 5.1

WIRE TO WIRE CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial **	10 milliohms MAXIMUM	20.07 mΩ	19.95 m Ω	20.50 mΩ
		After Durability $\Delta \ m \Omega$	20 milliohms MAXIMUM	0.31 mΩ	-0.02 mΩ	0.72 mΩ
		After Temperature Life Pre-Conditioned $\Delta \ m\Omega$	20 milliohms MAXIMUM	0.34 mΩ	0.07 mΩ	0.97 mΩ
	Contact	Thermal Cycling 167 Hours Δ mΩ	20 milliohms MAXIMUM	0.42 mΩ	0.10 mΩ	2.01 mΩ
4A	Resistance (Low Level)	Thermal Cycling 334 Hours Δ m Ω	20 milliohms MAXIMUM	0.41 mΩ	-0.06 mΩ	1.03 mΩ
		Thermal Cycling 500 Hours Δ m Ω	20 milliohms MAXIMUM	0.64 mΩ	0.03 mΩ	2.79 mΩ
		After Reseating Δ m Ω	20 milliohms MAXIMUM	0.54 mΩ	0.14 mΩ	2.45 mΩ

NOTES: ** APPROXIMATELY 16.6 m Ω OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE 13 INCHES OF WIRE USED IN SAMPLE PREPARATION.

SEE APPENDIX "A" FOR TEST SEQUENCE DESCRIPTION

DOCUMENT NUMBER: CREATED / REVISED BY: CHECKED BY: APPROVED BY: TS-43045-001 JDFOX SSOUSEK FSMITH	REVISION:	ECR/ECN INFORMATION: EC No: 109530 DATE: 2016 / 10 /18	N	TEST SUMMARY MICRO-FIT (3.0) CONNECTORS			

molex TEST SUMMARY

5.1 ELECTRICAL PERFORMANCE RESULTS (continued)

WIRE TO BOARD CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
4B	Contact Resistance (Low Level)	Initial	10 milliohms MAXIMUM	4.78 m $Ω$	4.56 m Ω	5.53 mΩ
		After Durability $\Delta \ m \Omega$	20 milliohms MAXIMUM	0.48 mΩ	0.06 mΩ	2.35 mΩ
		After Temperature Life Pre-Conditioned $\Delta \ m\Omega$	20 milliohms MAXIMUM	1.07 mΩ	0.13 mΩ	5.80 mΩ
		Thermal Cycling 167 Hours Δ mΩ	20 milliohms MAXIMUM	//UM 1.38 mΩ 0.30 mΩ		4.68 mΩ
		Thermal Cycling 334 Hours Δ m Ω	20 milliohms MAXIMUM	1.63 mΩ	0.31 mΩ	5.17 mΩ
		Thermal Cycling 500 Hours Δ m Ω	20 milliohms MAXIMUM	3.04 mΩ	0.69 mΩ	8.51 mΩ
		After Reseating Δ m Ω	20 milliohms MAXIMUM	3.48 mΩ	0.41 mΩ	8.94 mΩ

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE DESCRIPTION

REVISION: ECR/ECN INFORMATION:		TITLE: TEST SUMMARY		
09530		6 of 10		
016 / 10 /18	CONNECTORS			
DOCUMENT NUMBER:		CHECKED BY:	APPROVED BY:	
5-001	JDFOX	SSOUSEK	FSMITH	
	09530 016 / 10 /18	09530 N 016 / 10 /18 CREATED / REVISED BY:	09530 MICRO-FIT (3.0) 016 / 10 /18 CREATED / REVISED BY: CHECKED BY:	09530 MICRO-FIT (3.0) 016 / 10 /18 CONNECTORS CREATED / REVISED BY: CHECKED BY: APPROX

molex TEST SUMMARY

ELECTRICAL PERFORMANCE RESULTS (continued) 5.1

ITEM	DESCRIPTION	WIRE GAUGE	REQUIREMENT	AMPERAGE
	Temperature Rise	30 AWG	30°C Max. Temp. Rise	2.5 Amps
5		26 AWG	30°C Max. Temp. Rise	3.0 Amps
	Current Cycling	24 AWG	30°C Max. Temp. Rise	4.0 Amps
		20 AWG	30°C Max. Temp. Rise	5.5 Amps

5.2 **MECHANICAL PERFORMANCE RESULTS**

ITEM	DESCRIPTION	Wire Gauge	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		20 AWG	57.8 N Minimum	127.4	117.5	134.7
		22 AWG	35.6 N Minimum	86.1	80.2	90.4
6	Wire Pullout	24 AWG	22.2 N Minimum	53.6	44.7	58.08
	Force (Newtons)	26 AWG	13.3 N Minimum	36.1	33.8	38.3
		28 AWG	8.9 N Minimum	21.1	18.1	23.2
		30 AWG	6.6 N Minimum	18.2	13.5	24.6

ITEM	DESCRIPTION	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
7	Contact Normal Force (grams)	275 g Min	331 g	322 g	343 g

REVISION:	ECR/ECN INFORMATION:	TITLE:	TEST SUMMARY		
A2	EC No: 109530	N	MICRO-FIT (3.0)		7 of 10
AZ	DATE: 2016 / 10 /18		CONNECTORS		
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-43045-001		JDFOX	SSOUSEK	FSM	ITH



APPENDIX A TEST SEQUENCES

REVISION:	ECR/ECN INFORMATION: EC No: 109530	N	EST SUMMARY IICRO-FIT (3.0)		8 of 10	
- 1	DATE: 2016 / 10 /18		CONNECTORS			
<u>DOCUMEN</u>	ΓNUMBER:	CREATED / REVISED BY:	CHECKED BY:	<u>APPROV</u>	<u>'ED BY:</u>	
TS-43045-001		JDFOX	SSOUSEK	FSM	ITH	

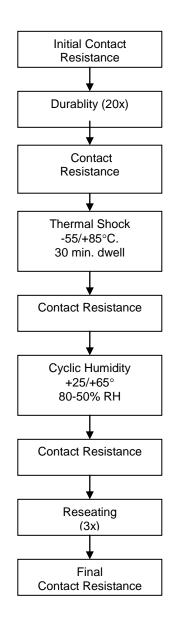
molex TEST SUMMARY

A.1 TEST SEQUENCES

SEQUENCE 1 1A Wire to Wire 1B Wire to Board

Initial Contact Resistance Durablity (20x) Contact Resistance Temperature Life 105°C. 240 hours Contact Resistance Reseating (3x)Final Contact Resistance

SEQUENCE 2 2A Wire to Wire 2B Wire to Board



REVISION:	ECR/ECN INFORMATION:	TITLE:	TLE: TEST SUMMARY			
Λ 2	EC No: 109530	N	IICRO-FIT (3.0)		9 of 10	
A2	DATE: 2016 / 10 /18	CONNECTORS				
DOCUMEN ⁻	Γ NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:	
TS-43045-001		JDFOX	SSOUSEK	FSM	ITH	
			TEMPLATE FILENA	ME: TEST_SUMMARY	[SIZE_A](V.1).DOC	

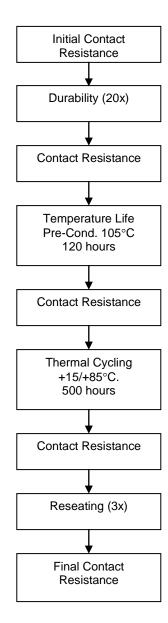
molex TEST SUMMARY

A.1 TEST SEQUENCES (continued)

SEQUENCE 3 3A Wire to Wire 3B Wire to Board

Initial Contact Resistance Durability (20x) Contact Resistance Temperature Life Pre-Cond. 105°C 120 hours Contact Resistance Random Vibration (with Discontinuity) **Final Contact** Resistance

SEQUENCE 4 4A Wire to Wire 4B Wire to Board



REVISION:	ECR/ECN INFORMATION: EC No: 109530	TEST SUMMARY MICRO-FIT (3.0)			SHEET No. 10 of 10
AZ	DATE: 2016 / 10 /18	(CONNECTÒRS		
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-43045-001		JDFOX	SSOUSEK	FSM	ITH

TEST SUMMARY

Micro-Fit (3.0) **Connector System** (Wire to Wire & Wire to Board - Gold Plating)

1.0 SCOPE

This Test Specification covers the 3.00 mm (.118 inch) centerline (pitch) connector series terminated with 20-30 AWG wire using crimp technology and gold plating on the contact interfaces.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME, SERIES, AND PART NUMBER(S)

Micro-Fit (3.0) Receptacle Series: 43025, 43645, 44133 (BMI)

Micro-Fit (3.0) Plug Series: 43020, 43640, 44300 (BMI)

Micro-Fit (3.0) Right Angle & Vertical Header Series: 43045, 43650, 44067

Micro-Fit (3.0) Compliant Pin Vertical Header Series: 44914

Micro-Fit (3.0) Female Crimp Terminal Series: 43030 Micro-Fit (3.0) Male Crimp Terminal Series: 43031

Micro-Fit (3.0) Female Crimp Terminal with Lubricant: 45773

2.1.1 SERIES NUMBERS TESTED

Micro-Fit (3.0) Receptacle: 43025

Micro-Fit (3.0) Plug: 43020

Micro-Fit (3.0) Right Angle & Vertical Headers: 43045

Micro-Fit (3.0) Female Crimp Terminal: 43030 Micro-Fit (3.0) Male Crimp Terminal: 43031

Micro-Fit (3.0) Female Crimp Terminal with Lubricant: 45773

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See the appropriate sales drawings for information on dimensions, materials, plating, and markings.

2.3 PRODUCT SPECIFICATION TITLE AND DOCUMENT NUMBER

Product Specification Micro-Fit Dual Row Connectors

Document Number: PS-43045

Product Specification Micro-Fit Single Row Connectors

Document Number: PS-43650

Product Specification Micro-Fit (3.0) BMI Floating Connector System

Document Number: PS-44300-001

REVISION:	ECR/ECN INFORMATION:	TITLE:	TEST SUMMARY		SHEET No.
A 4	EC No: 109530	N	MICRO-FIT (3.0)		1 of 11
A 1	DATE: 2016 / 10 /19		V CONNECTOŔS ((GOLD)	
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-43045-002		JDFOX	SSOUSEK	FSM	ITH

molex[®]

TEST SUMMARY

3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

3.1 TESTING PROCEDURES, SEQUENCES, AND SPECIFICATIONS

NPS-25298-2

EIA-364-65A

EIA-364-1000.01

MIL-STD-202 METHOD 213

MIL-STD-202 METHOD 204

3.2 OTHER DOCUMENTS AND SPECIFICATIONS

None

4.0 QUALIFICATION

Laboratory conditions and sample selection are in accordance with EIA-364 and NPS-25298-2.

5.0 PERFORMANCE RESULTS

5.1 ELECTRICAL PERFORMANCE RESULTS

WIRE TO WIRE CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial **		17.84 mΩ	17.69 mΩ	18.34 mΩ
	CONTACT	After Vibration	10 milliohms MAXIMUM	0.05 mΩ	-0.49 mΩ	0.46 mΩ
1A	RESISTANCE	(LOW LEVEL)	No Discontinuity	Discontin	uity < 1 mic	rosecond
	(LOW LEVEL)		10 milliohms MAXIMUM	0.12 mΩ	-0.41 mΩ	0.48 mΩ
	!	Δ m Ω	No Discontinuity	Discontin	uity < 1 mic	rosecond

NOTE: ** A PORTION OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE WIRE **USED IN SAMPLE PREPARATION.**

WIRE TO BOARD CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial		9.85 m Ω	9.66 m Ω	10.02 mΩ
	CONTACT	After Vibration	10 milliohms MAXIMUM	-0.07 mΩ	-0.21 mΩ	0.00 mΩ
1B	RESISTANCE		No Discontinuity	Discontin	uity < 1 mic	rosecond
	(LOW LEVEL)	After Mechanical Shock	10 milliohms MAXIMUM	-0.02 mΩ	-0.15 mΩ	0.09 mΩ
		Δ m Ω	No Discontinuity	Discontin	uity < 1 mic	rosecond

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE "1" DESCRIPTION

REVISION:	ECR/ECN INFORMATION:	TITLE: T I	TLE: TEST SUMMARY		SHEET No.		
A 4	EC No: 109530	N	IICRO-FIT (3.0)		2 of 11		
A 1	DATE: 2016 / 10 /19		DUAL ROW CONNECTORS (GOLD)				
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	<u>APPRO</u> \	/ED BY:		
TS-43045-002		JDFOX	SSOUSEK	FSM	ITH		
			TEMPLATE EILENIA	MAE: TEST SUMMADY	TEIZE ATVV 1) DOC		

TEST SUMMARY

5.1 ELECTRICAL PERFORMANCE RESULTS (continued)

WIRE TO WIRE CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial **		17.84 m Ω	17.70 mΩ	17.98 m Ω
2A	Contact Resistance	After Thermal Shock Δ m Ω	10 milliohms MAXIMUM	0.05 mΩ	-0.02 mΩ	0.21 mΩ
	(Low Level)	After Cyclic Humidity $\Delta \ \text{m}\Omega$	10 milliohms MAXIMUM	0.04 mΩ	-0.08 mΩ	0.64 mΩ

NOTE: ** A PORTION OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE WIRE **USED IN SAMPLE PREPARATION.**

WIRE TO BOARD CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial		5.01 m Ω	4.83 mΩ	5.36 m Ω
2B	Contact Resistance	After Thermal Shock $\Delta~\text{m}\Omega$	10 milliohms MAXIMUM	-0.01 mΩ	-0.15 mΩ	0.16 mΩ
	(Low Level)	After Cyclic Humidity $\Delta \ \text{m}\Omega$	10 milliohms MAXIMUM	-0.02 mΩ	-0.15 mΩ	0.19 mΩ

ITEM 2C AND 2D:

ALL OF THE SAMPLES USED IN THE SEQUENCE "2" (GROUP 2) INSULATION RESISTANCE AND DIELECTRIC WITHSTANDING VOLTAGE TESTING PASSED WITHOÙT FAILURE (WIRE TO WIRE AND WIRE TO BOARD).

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE "2" DESCRIPTION

WIRE TO WIRE CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
	Contact	Initial **		17.84 mΩ	17.64 mΩ	19.99 mΩ
3A	Resistance (Low Level)	After Thermal Aging $\Delta \ \text{m}\Omega$	10 milliohms MAXIMUM	0.07 mΩ	-1.09 mΩ	0.16 mΩ

NOTE: ** A PORTION OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE WIRE **USED IN SAMPLE PREPARATION.**

REVISION:	ECR/ECN INFORMATION:	TEST SUMMARY			SHEET No.		
A1	EC No: 109530	N	IICRO-FIT (3.0)		3 of 11		
Ai	DATE: 2016 / 10 /19						
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPROVED BY:			
TS-43045-002		JDFOX	SSOUSEK	FSMITH			
	TEMPI ATE EII ENIAME: TEST, SLIMMADVISI						

TEST SUMMARY

5.1 ELECTRICAL PERFORMANCE RESULTS (continued)

WIRE TO BOARD CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
	Contact	Initial		4.98 m Ω	4.87 m Ω	5.20 m Ω
3B	Resistance (Low Level)	After Thermal Aging $\Delta \ \text{m}\Omega$	10 milliohms MAXIMUM	0.03 mΩ	-0.03 mΩ	0.10 mΩ

SEE APPENDIX "A" FOR TEST SEQUENCE "3" DESCRIPTION

43030 FEMALE CRIMP TERMINAL

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial		3.27 m Ω	3.15 m $Ω$	3.41 m Ω
4A L o	Contact Resistance	After Thermal Age $_{\Delta}$ m $_{\Omega}$	10 milliohms MAXIMUM	0.02 mΩ	-0.01 mΩ	0.04 mΩ
1	(Low Level)	After Tensile Strength Δ m Ω	10 milliohms MAXIMUM	0.02 mΩ	-0.02 mΩ	0.04 mΩ

43031 MALE CRIMP TERMINAL

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial		3.31 m Ω	3.17 m Ω	3.40 m Ω
4B L o	Contact Resistance	After Thermal Age Δ m Ω	10 milliohms MAXIMUM	0.02 mΩ	0.00 mΩ	0.04 mΩ
1	(Low Level)	After Tensile Strength $\Delta \ \text{m}\Omega$	10 milliohms MAXIMUM	0.02 mΩ	0.00 mΩ	0.05 mΩ

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE "4" DESCRIPTION

REVISION:	ECR/ECN INFORMATION:	TITLE: T I	EST SUMMARY		SHEET No.
A1	EC No: 109530	N	IICRO-FIT (3.0)		4 of 11
AT	DATE: 2016 / 10 /19	DUAL ROV	/ CONNECTORS (GOLD)	
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPROVED BY:	
TS-43045-002		JDFOX	SSOUSEK	FSM	ITH
		-	TEMPI ATE EII ENA	ME-TEST SUMMARY	(ISIZE AVV 1) DOC

TEST SUMMARY

5.1 ELECTRICAL PERFORMANCE RESULTS (continued)

43030 FEMALE CRIMP TERMINAL

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial		3.45 m Ω	3.24 m Ω	3.74 mΩ
4A L o	Contact Resistance	After Thermal Age $_{\Delta}$ m $_{\Omega}$	10 milliohms MAXIMUM	0.00 mΩ	-0.01 mΩ	0.02 mΩ
2	(Low Level)	After Gas Tightness Δ m Ω	10 milliohms MAXIMUM	0.01 mΩ	0.00 mΩ	0.05 mΩ

43031 MALE CRIMP TERMINAL

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial		3.48 m Ω	3.25 m Ω	3.73 mΩ
4B L o	Contact Resistance	After Thermal Age Δ m Ω	10 milliohms MAXIMUM	0.01 mΩ	-0.01 mΩ	0.03 mΩ
2	(Low Level)	After Gas Tightness Δ m Ω	10 milliohms MAXIMUM	0.02 mΩ	-0.01 mΩ	0.05 mΩ

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE "4" DESCRIPTION

REVISION:	ECR/ECN INFORMATION:	TEST SUMMARY			SHEET No.
A1	EC No: 109530	N	IICRO-FIT (3.0)		5 of 11
AI	DATE: 2016 / 10 /19	DUAL ROW	/ CONNECTORS (GOLD)	
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	<u>APPROV</u>	/ED BY:
TS-43045-002		JDFOX	SSOUSEK	FSMITH	

TEST SUMMARY

5.1 ELECTRICAL PERFORMANCE RESULTS (continued)

NOTE: The following Mixed Flowing Gas Testing results are for the MicroFit Female Crimp Terminal 45773 series (43030 series terminal with environmental lube applied).

WIRE TO WIRE CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial **		18.16 m Ω	18.03 m Ω	18.59 m Ω
		After Durability $\Delta \ m \Omega$	10 milliohms MAXIMUM	-0.12 mΩ	-0.67 mΩ	0.03 mΩ
		After Unmated 5 days Δ m Ω	10 milliohms MAXIMUM	-0.05 mΩ	-0.57 mΩ	0.65 mΩ
5A	Contact Resistance	After Unmated 10 days $\Delta~\text{m}\Omega$	10 milliohms MAXIMUM	0.05 mΩ	-1.10 mΩ	1.05 mΩ
	(Low Level)	After Mated 15 days Δ m Ω	10 milliohms MAXIMUM	0.04 mΩ	-0.12 mΩ	0.24 mΩ
		After Mated 20 days Δ m Ω	10 milliohms MAXIMUM	-0.01 mΩ	-0.99 mΩ	2.57 mΩ
		After Durability $\Delta \ m \Omega$	10 milliohms MAXIMUM	-0.22 mΩ	-2.58 mΩ	0.50 mΩ

NOTE: ** A PORTION OF THE MEASUREMENT VALUE IS ATTRIBUTED TO THE BULK RESISTANCE OF THE WIRE USED IN SAMPLE PREPARATION.

WIRE TO BOARD CONFIGURATION

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
		Initial		5.24 m Ω	5.09 mΩ	5.42 m Ω
		After Durability $\Delta \ m \Omega$	10 milliohms MAXIMUM	-0.01 mΩ	-0.32 mΩ	0.24 mΩ
		After Unmated 5 days Δ m Ω	10 milliohms MAXIMUM	0.03 mΩ	-0.30 mΩ	1.03 mΩ
5B	Contact Resistance	After Unmated 10 days $\Delta \ \text{m}\Omega$	10 milliohms MAXIMUM	0.00 mΩ	-0.36 mΩ	0.18 mΩ
	(Low Level)	After Mated 15 days Δ m Ω	10 milliohms MAXIMUM	0.09 mΩ	-0.33 mΩ	0.58 mΩ
		After Mated 20 days Δ m Ω	10 milliohms MAXIMUM	0.04 mΩ	-0.29 mΩ	0.42 mΩ
		After Durability $\Delta \ m \Omega$	10 milliohms MAXIMUM	0.11 mΩ	-0.11 mΩ	0.39 mΩ

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE "5" DESCRIPTION

ECR/ECN INFORMATION:	TITLE:	TEST SUMMARY		SHEET No.
EC No: 109530				6 of 11
DATE: 2016 / 10 /19	DUAL ROW	/ CONNECTORS (GOLD)	
NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
S-43045-002	JDFOX	SSOUSEK	FSMITH	
	EC No: 109530 DATE: 2016 / 10 /19 NUMBER:	EC No: 109530 N DATE: 2016 / 10 /19 DUAL ROW NUMBER: CREATED / REVISED BY:	EC No: 109530 MICRO-FIT (3.0) DATE: 2016 / 10 /19 DUAL ROW CONNECTORS (NUMBER: CREATED / REVISED BY: CHECKED BY:	EC No: 109530 MICRO-FIT (3.0) DATE: 2016 / 10 /19 DUAL ROW CONNECTORS (GOLD) NUMBER: CREATED / REVISED BY: CHECKED BY: APPROX

TEST SUMMARY

5.2 MECHANICAL PERFORMANCE RESULTS

ITEM	DESCRIPTION	TREATMENT	REQUIREMENT	MEAN	MINIMUM	MAXIMUM
3C	Contact Normal Force (grams)	Initial	275 g Min	443 g	413 g	466 g
30		After Thermal Age	275 g Min	292 g	285 g	297 g

NOTE: SEE APPENDIX "A" FOR TEST SEQUENCE "3" DESCRIPTION

REVISION:	ECR/ECN INFORMATION:	TEST SUMMARY			SHEET No.
A 4	EC No: 109530	N	IICRO-FIT (3.0)		7 of 11
A1	DATE: 2016 / 10 /19		/ CONNECTORS (GOLD)	
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-43045-002		JDFOX	SSOUSEK	FSM	ITH



TEST SUMMARY

APPENDIX A

TEST SEQUENCES

A1

REVISION:

ECR/ECN INFORMATION:
EC No: 109530

DATE: 2016 / 10 /19

TITLE: TEST SUMMARY
MICRO-FIT (3.0)
DUAL ROW CONNECTORS (GOLD)

SHEET No.

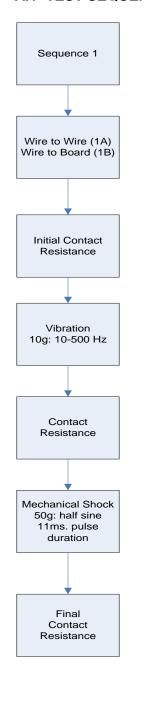
8 of **11**

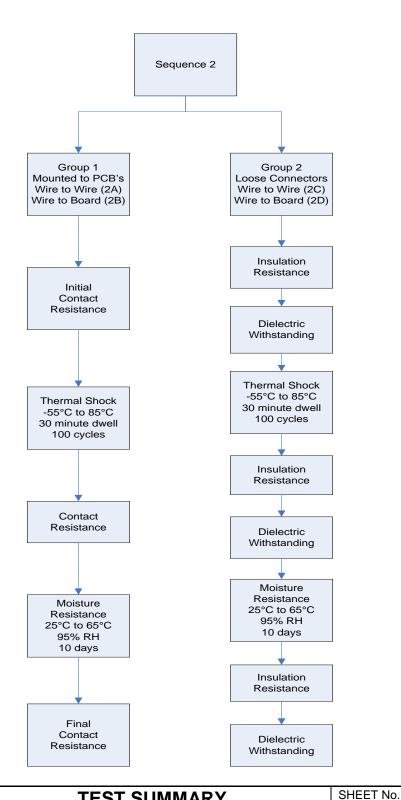
 DOCUMENT NUMBER:
 CREATED / REVISED BY:
 CHECKED BY:
 APPROVED BY:

 TS-43045-002
 JDFOX
 SSOUSEK
 FSMITH

TEST SUMMARY

A.1 TEST SEQUENCES





REVISION: ECR/ECN INFORMATION:
EC No: 109530
DATE: 2016 / 10 /19

TS-43045-002

DOCUMENT NUMBER:

TITLE:

JDFOX

TEST SUMMARY
MICRO-FIT (3.0)
DUAL ROW CONNECTORS (GOLD)

SSOUSEK

9 of **11**

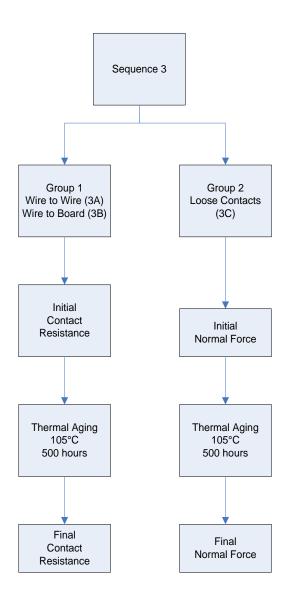
CREATED / REVISED BY: CHECKED BY: APPROVED BY:

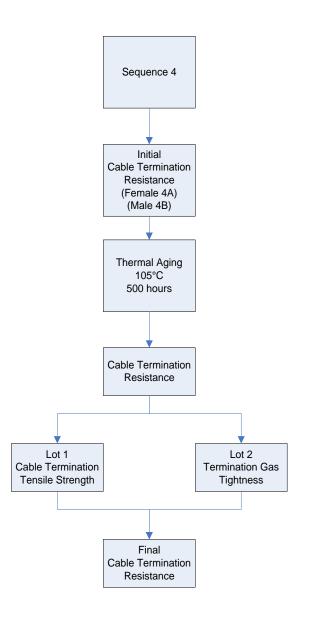
TEMPLATE FILENAME: TEST_SUMMARY[SIZE_A](V.1).DOC

FSMITH

TEST SUMMARY

A.1 TEST SEQUENCES (continued)



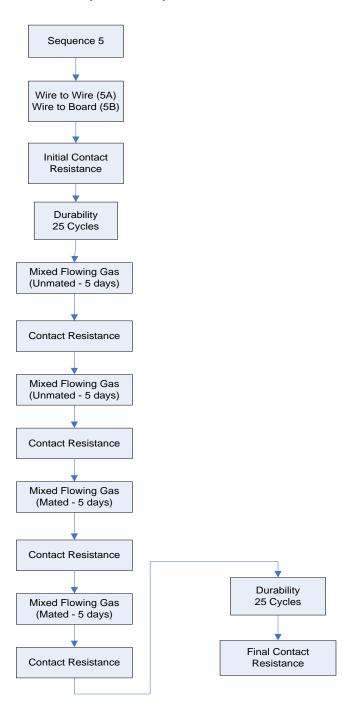


REVISION:	ECR/ECN INFORMATION:	TITLE: TEST SUMMARY			SHEET No.
A 4	EC No: 109530	N	IICRO-FIT (3.0)		10 of 11
A 1	DATE: 2016 / 10 /19		/ CONNECTORS ((GOLD)	
DOCUMENT NUMBER:		CREATED / REVISED BY:	SY: CHECKED BY: APPROV		/ED BY:
TO 4004E 000		IDEOV	000110514	E014	

JDFOX SSOUSEK FSMITH TS-43045-002

TEST SUMMARY

A.1 TEST SEQUENCES (continued)



REVISION:	ECR/ECN INFORMATION:	TEST SUMMARY			SHEET No.
A 4	EC No: 109530	N	IICRO-FIT (3.0)		11 of 11
A 1	DATE: 2016 / 10 /19		/ CONNECTOŔS ((GOLD)	
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
TS-43045-002		JDFOX	SSOUSEK	FSMITH	
TEMPLATE FUENAME, TEST SUMMARVISIZE AVVAI DOS					